

Application/Control No.	Applicant(s)/Patent under Reexamination
10/644,100	LICH ET AL.
Examiner	Art Unit
Drew J. Brown	3616

	SEARCHED					
Class	Subclass	Date	Examiner			
280	735	7/13/2005	DB			
180	271	7/13/2005	DB			
180	282	7/13/2005	D3			
340	667	7/12/2005	DA			
307	10.1	7/12/2005	Di3			

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
Paul Dickson		7/13/2005	Dß	
David Dunn		7/13/2005	DB	
Peter English		7/13/2005	DB	
See Attachment		7/13/2005	DB	